

Search Notes

Application/Control No.

10/621,006

Examiner

Benjamin P. Blumel

Applicant(s)/Patent under
Reexamination

DAVIDSON ET AL.

Art Unit

1648

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
STIC searched SEQ ID NO:1 and 12			

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	5/22/2007	BPB
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